

Notice of References Cited	Application/Control No. 10/825,363	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner DANIEL TSEGAYE	Art Unit 2609	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,462,735	10-2002	Naito, Keijiro	345/204
*	B	US-2002/0063666	05-2002	Kang et al.	345/87
*	C	US-7,030,842	04-2006	Ha et al.	345/76
*	D	US-2001/0028335	10-2001	Hasegawa et al.	345/76
*	E	US-2002/0158882	10-2002	Liaw et al.	345/589
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Included as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.